



National Standards Authority of Ireland

IRISH STANDARD

I.S. EN 60749-2:2002

ICS 31.080.01

**SEMICONDUCTOR DEVICES -
MECHANICAL AND CLIMATIC TEST
METHODS
PART 2: LOW AIR PRESSURE
(IEC 60749-2:2002)**

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EUROPEAN STANDARD

EN 60749-2

NORME EUROPÉENNE

EUROPÄISCHE NORM

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Partly supersedes EN 60749 1999 + A1:2000 + A2 2001

English version

**Semiconductor devices -
Mechanical and climatic test methods
Part 2: Low air pressure
(IEC 60749-2:2002)**

Dispositifs à semiconducteurs -
Méthodes d'essais mécaniques
et climatiques
Partie 2: Basse pression atmosphérique
(CEI 60749-2:2002)

Halbleiterbauelemente -
Mechanische und klimatische
Prüfverfahren
Teil 2: Niedriger Luftdruck
(IEC 60749-2:2002)

This European Standard was approved by CENELEC on 2002-07-02. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the Central Secretariat or to any CENELEC member.

This European Standard exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the Central Secretariat has the same status as the official versions.

CENELEC members are the national electrotechnical committees of Austria, Belgium, Czech Republic, Denmark, Finland, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Luxembourg, Malta, Netherlands, Norway, Portugal, Slovakia, Spain, Sweden, Switzerland and United Kingdom.

CENELEC

European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

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Foreword

The text of document 47/1601/FDIS, future edition 1 of IEC 60749-2, prepared by IEC TC 47, Semiconductor devices, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 60749-2 on 2002-07-02.

This mechanical and climatic test method, as it relates to low air pressure, is a complete rewrite of the test contained in clause 3, chapter 3 of EN 60749:1999.

The following dates were fixed:

- latest date by which the EN has to be implemented
at national level by publication of an identical
national standard or by endorsement (dop) 2003-04-01
- latest date by which the national standards conflicting
with the EN have to be withdrawn (dow) 2005-07-01

Annexes designated "normative" are part of the body of the standard.

In this standard, annex ZA is normative.

Annex ZA has been added by CENELEC.

Endorsement notice

The text of the International Standard IEC 60749-2:2002 was approved by CENELEC as a European Standard without any modification.

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